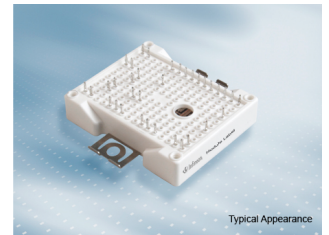


## EasyPACK™ module with Trench/Fieldstop IGBT H3 and rapid diode and PressFIT / NTC

### Features

- Electrical features
  - $V_{CES} = 650\text{ V}$
  - $I_{C\text{nom}} = 100\text{ A} / I_{CRM} = 200\text{ A}$
  - Increased blocking voltage capability up to 650 V
  - Low inductive design
  - Low switching losses
  - Low  $V_{CE,sat}$
- Mechanical features
  - $\text{Al}_2\text{O}_3$  substrate with low thermal resistance
  - Compact design
  - PressFIT contact technology
  - Rugged mounting due to integrated mounting clamps



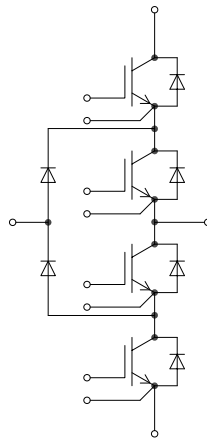
### Potential applications

- Three-level applications
- Motor drives
- Solar applications
- UPS systems

### Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

### Description



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## 1 Package

**Table 1 Insulation coordination**

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	$V_{ISOL}$	RMS, $f = 50 \text{ Hz}$ , $t = 1 \text{ min}$	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	$Al_2O_3$	
Creepage distance	$d_{Creep}$	terminal to heatsink	11.5	mm
Creepage distance	$d_{Creep}$	terminal to terminal	6.3	mm
Clearance	$d_{Clear}$	terminal to heatsink	10.0	mm
Clearance	$d_{Clear}$	terminal to terminal	5.0	mm
Comparative tracking index	$CTI$		>200	
Relative thermal index (electrical)	$RTI$	housing	140	°C

**Table 2 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	$L_{SCE}$			14		nH
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25^\circ\text{C}$ , per switch		2.8		mΩ
Storage temperature	$T_{stg}$		-40		125	°C
Mounting force per clamp	$F$		40		80	N
Weight	$G$			39		g

Note: The current under continuous operation is limited to 25A rms per connector pin

## 2 IGBT, T1 / T4

**Table 3 Maximum rated values**

Parameter	Symbol	Note or test condition		Values	Unit
Collector-emitter voltage	$V_{CES}$		$T_{vj} = 25^\circ\text{C}$	650	V
Implemented collector current	$I_{CN}$			100	A
Continuous DC collector current	$I_{CDC}$	$T_{vj \text{ max}} = 175^\circ\text{C}$	$T_H = 65^\circ\text{C}$	70	A
Repetitive peak collector current	$I_{CRM}$	$t_p = 1 \text{ ms}$		200	A
Gate-emitter peak voltage	$V_{GES}$			±20	V

**Table 4 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Collector-emitter saturation voltage	$V_{CE\ sat}$	$I_C = 100\ A, V_{GE} = 15\ V$	$T_{vj} = 25\ ^\circ C$		1.68	2.00	V
			$T_{vj} = 125\ ^\circ C$		1.86		
			$T_{vj} = 150\ ^\circ C$		1.89		
Gate threshold voltage	$V_{GEth}$	$I_C = 1.6\ mA, V_{CE} = V_{GE}, T_{vj} = 25\ ^\circ C$		5.05	5.75	6.45	V
Gate charge	$Q_G$	$V_{GE} = \pm 15\ V, V_{CE} = 400\ V$			1		$\mu C$
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25\ ^\circ C$			0		$\Omega$
Input capacitance	$C_{ies}$	$f = 100\ kHz, T_{vj} = 25\ ^\circ C, V_{CE} = 650\ V, V_{GE} = 0\ V$			5.9		nF
Reverse transfer capacitance	$C_{res}$	$f = 100\ kHz, T_{vj} = 25\ ^\circ C, V_{CE} = 650\ V, V_{GE} = 0\ V$			0.192		nF
Collector-emitter cut-off current	$I_{CES}$	$V_{CE} = 650\ V, V_{GE} = 0\ V$	$T_{vj} = 25\ ^\circ C$			0.008	mA
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 650\ V, V_{GE} = 0\ V, T_{vj} = 25\ ^\circ C$				100	nA
Turn-on delay time (inductive load)	$t_{don}$	$I_C = 100\ A, V_{CE} = 300\ V, V_{GE} = \pm 15\ V, R_{Gon} = 5.1\ \Omega$	$T_{vj} = 25\ ^\circ C$		0.026		$\mu s$
			$T_{vj} = 125\ ^\circ C$		0.027		
			$T_{vj} = 150\ ^\circ C$		0.027		
Rise time (inductive load)	$t_r$	$I_C = 100\ A, V_{CE} = 300\ V, V_{GE} = \pm 15\ V, R_{Gon} = 5.1\ \Omega$	$T_{vj} = 25\ ^\circ C$		0.028		$\mu s$
			$T_{vj} = 125\ ^\circ C$		0.038		
			$T_{vj} = 150\ ^\circ C$		0.040		
Turn-off delay time (inductive load)	$t_{doff}$	$I_C = 100\ A, V_{CE} = 300\ V, V_{GE} = \pm 15\ V, R_{Goff} = 5.1\ \Omega$	$T_{vj} = 25\ ^\circ C$		0.200		$\mu s$
			$T_{vj} = 125\ ^\circ C$		0.220		
			$T_{vj} = 150\ ^\circ C$		0.230		
Fall time (inductive load)	$t_f$	$I_C = 100\ A, V_{CE} = 300\ V, V_{GE} = \pm 15\ V, R_{Goff} = 5.1\ \Omega$	$T_{vj} = 25\ ^\circ C$		0.044		$\mu s$
			$T_{vj} = 125\ ^\circ C$		0.081		
			$T_{vj} = 150\ ^\circ C$		0.091		
Turn-on energy loss per pulse	$E_{on}$	$I_C = 100\ A, V_{CE} = 300\ V, L_\sigma = 35\ nH, V_{GE} = \pm 15\ V, R_{Gon} = 5.1\ \Omega, di/dt = 3400\ A/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		2.2		mJ
			$T_{vj} = 125\ ^\circ C$		2.71		
			$T_{vj} = 150\ ^\circ C$		2.75		
Turn-off energy loss per pulse	$E_{off}$	$I_C = 100\ A, V_{CE} = 300\ V, L_\sigma = 35\ nH, V_{GE} = \pm 15\ V, R_{Goff} = 5.1\ \Omega, dv/dt = 5200\ V/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		1.44		mJ
			$T_{vj} = 125\ ^\circ C$		2.14		
			$T_{vj} = 150\ ^\circ C$		2.38		
Thermal resistance, junction to heat sink	$R_{thJH}$	per IGBT			0.782		K/W
Temperature under switching conditions	$T_{vj\ op}$			-40		150	$^\circ C$

### 3 IGBT, T2 / T3

**Table 5** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Collector-emitter voltage	$V_{CES}$	$T_{vj} = 25\text{ °C}$	650	V
Implemented collector current	$I_{CN}$		100	A
Continuous DC collector current	$I_{CDC}$	$T_{vj\text{ max}} = 175\text{ °C}$ $T_H = 65\text{ °C}$	70	A
Repetitive peak collector current	$I_{CRM}$	$t_p = 1\text{ ms}$	200	A
Gate-emitter peak voltage	$V_{GES}$		±20	V

**Table 6** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Collector-emitter saturation voltage	$V_{CE\text{ sat}}$	$I_C = 100\text{ A}$ , $V_{GE} = 15\text{ V}$	$T_{vj} = 25\text{ °C}$	1.45	1.90	V
			$T_{vj} = 125\text{ °C}$	1.61		
			$T_{vj} = 150\text{ °C}$	1.68		
Gate threshold voltage	$V_{GEth}$	$I_C = 1.6\text{ mA}$ , $V_{CE} = 20\text{ V}$ , $T_{vj} = 25\text{ °C}$	5.05	5.75	6.45	V
Gate charge	$Q_G$	$V_{GE} = \pm 15\text{ V}$ , $V_{CE} = 400\text{ V}$		1		μC
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25\text{ °C}$		0		Ω
Input capacitance	$C_{ies}$	$f = 100\text{ kHz}$ , $T_{vj} = 25\text{ °C}$ , $V_{CE} = 650\text{ V}$ , $V_{GE} = 0\text{ V}$		6.2		nF
Reverse transfer capacitance	$C_{res}$	$f = 100\text{ kHz}$ , $T_{vj} = 25\text{ °C}$ , $V_{CE} = 650\text{ V}$ , $V_{GE} = 0\text{ V}$		0.19		nF
Collector-emitter cut-off current	$I_{CES}$	$V_{CE} = 650\text{ V}$ , $V_{GE} = 0\text{ V}$ $T_{vj} = 25\text{ °C}$			0.032	mA
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 650\text{ V}$ , $V_{GE} = 0\text{ V}$ , $T_{vj} = 25\text{ °C}$			100	nA
Turn-on delay time (inductive load)	$t_{don}$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Gon} = 1.5\text{ } \Omega$	$T_{vj} = 25\text{ °C}$	0.014		μs
			$T_{vj} = 125\text{ °C}$	0.015		
			$T_{vj} = 150\text{ °C}$	0.015		
Rise time (inductive load)	$t_r$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Gon} = 1.5\text{ } \Omega$	$T_{vj} = 25\text{ °C}$	0.014		μs
			$T_{vj} = 125\text{ °C}$	0.021		
			$T_{vj} = 150\text{ °C}$	0.022		
Turn-off delay time (inductive load)	$t_{doff}$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Goff} = 1.5\text{ } \Omega$	$T_{vj} = 25\text{ °C}$	0.168		μs
			$T_{vj} = 125\text{ °C}$	0.194		
			$T_{vj} = 150\text{ °C}$	0.201		
Fall time (inductive load)	$t_f$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Goff} = 1.5\text{ } \Omega$	$T_{vj} = 25\text{ °C}$	0.107		μs
			$T_{vj} = 125\text{ °C}$	0.156		
			$T_{vj} = 150\text{ °C}$	0.172		

(table continues...)  
Datasheet

**Table 6** (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-on energy loss per pulse	$E_{on}$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $L_\sigma = 35\text{ nH}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Gon} = 1.5\ \Omega$ , $di/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ }^\circ\text{C}$ )	$T_{vj} = 25\text{ }^\circ\text{C}$	0.261		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	0.469		
			$T_{vj} = 150\text{ }^\circ\text{C}$	0.538		
Turn-off energy loss per pulse	$E_{off}$	$I_C = 100\text{ A}$ , $V_{CE} = 300\text{ V}$ , $L_\sigma = 35\text{ nH}$ , $V_{GE} = \pm 15\text{ V}$ , $R_{Goff} = 1.5\ \Omega$ , $dv/dt = 3600\text{ V}/\mu\text{s}$ ( $T_{vj} = 150\text{ }^\circ\text{C}$ )	$T_{vj} = 25\text{ }^\circ\text{C}$	2.45		mJ
			$T_{vj} = 125\text{ }^\circ\text{C}$	3.31		
			$T_{vj} = 150\text{ }^\circ\text{C}$	3.53		
Thermal resistance, junction to heat sink	$R_{thJH}$	per IGBT		0.782		K/W
Temperature under switching conditions	$T_{vj\text{ op}}$		-40		150	$^\circ\text{C}$

## 4 Diode, D1 / D4

**Table 7** **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ }^\circ\text{C}$	650	V	
Continuous DC forward current	$I_F$		100	A	
Repetitive peak forward current	$I_{FRM}$	$t_p = 1\text{ ms}$	200	A	
$I^2t$ - value	$I^2t$	$V_R = 0\text{ V}$ , $t_p = 10\text{ ms}$	$T_{vj} = 125\text{ }^\circ\text{C}$	1750	$\text{A}^2\text{s}$
			$T_{vj} = 150\text{ }^\circ\text{C}$	1650	

**Table 8** **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Forward voltage	$V_F$	$I_F = 100\text{ A}$ , $V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		1.55	1.95	V
			$T_{vj} = 125\text{ }^\circ\text{C}$		1.50		
			$T_{vj} = 150\text{ }^\circ\text{C}$		1.45		
Peak reverse recovery current	$I_{RM}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ }^\circ\text{C}$ )	$T_{vj} = 25\text{ }^\circ\text{C}$		87.9		A
			$T_{vj} = 125\text{ }^\circ\text{C}$		102		
			$T_{vj} = 150\text{ }^\circ\text{C}$		104		

(table continues...)

**Table 8 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Recovered charge	$Q_r$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	3.77		$\mu\text{C}$
			$T_{vj} = 125\text{ °C}$	7.07		
			$T_{vj} = 150\text{ °C}$	8.26		
Reverse recovery energy	$E_{rec}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	0.835		mJ
			$T_{vj} = 125\text{ °C}$	1.52		
			$T_{vj} = 150\text{ °C}$	1.73		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		0.975		K/W
Temperature under switching conditions	$T_{vj\text{ op}}$		-40		150	$^{\circ}\text{C}$

## 5 Diode, D2 / D3

**Table 9 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ °C}$	650	V	
Continuous DC forward current	$I_F$		100	A	
Repetitive peak forward current	$I_{FRM}$	$t_p = 1\text{ ms}$	200	A	
$I^2t$ - value	$I^2t$	$V_R = 0\text{ V}$ , $t_p = 10\text{ ms}$	$T_{vj} = 125\text{ °C}$	1750	$\text{A}^2\text{s}$
			$T_{vj} = 150\text{ °C}$	1650	

**Table 10 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 100\text{ A}$ , $V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	1.55	1.95	V
			$T_{vj} = 125\text{ °C}$	1.50		
			$T_{vj} = 150\text{ °C}$	1.45		
Peak reverse recovery current	$I_{RM}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	87.9		A
			$T_{vj} = 125\text{ °C}$	102		
			$T_{vj} = 150\text{ °C}$	104		

(table continues...)

**Table 10** (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Recovered charge	$Q_r$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	3.77		$\mu\text{C}$
			$T_{vj} = 125\text{ °C}$	7.07		
			$T_{vj} = 150\text{ °C}$	8.26		
Reverse recovery energy	$E_{rec}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3900\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	0.835		mJ
			$T_{vj} = 125\text{ °C}$	1.52		
			$T_{vj} = 150\text{ °C}$	1.73		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		0.975		K/W
Temperature under switching conditions	$T_{vj\text{ op}}$		-40		150	$^{\circ}\text{C}$

## 6 Diode, D5 / D6

**Table 11** **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ °C}$	650	V	
Continuous DC forward current	$I_F$		100	A	
Repetitive peak forward current	$I_{FRM}$	$t_p = 1\text{ ms}$	200	A	
$I^2t$ - value	$I^2t$	$V_R = 0\text{ V}$ , $t_p = 10\text{ ms}$	$T_{vj} = 125\text{ °C}$	1670	$\text{A}^2\text{s}$
			$T_{vj} = 150\text{ °C}$	1540	

**Table 12** **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 100\text{ A}$ , $V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	1.65	2.15	V
			$T_{vj} = 125\text{ °C}$	1.55		
			$T_{vj} = 150\text{ °C}$	1.50		
Peak reverse recovery current	$I_{RM}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3400\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	63.8		A
			$T_{vj} = 125\text{ °C}$	81.4		
			$T_{vj} = 150\text{ °C}$	85.3		

(table continues...)



**Table 12 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Recovered charge	$Q_r$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3400\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	3.68		$\mu\text{C}$
			$T_{vj} = 125\text{ °C}$	5.42		
			$T_{vj} = 150\text{ °C}$	6.06		
Reverse recovery energy	$E_{rec}$	$I_F = 100\text{ A}$ , $V_R = 300\text{ V}$ , $V_{GE} = -15\text{ V}$ , $-di_F/dt = 3400\text{ A}/\mu\text{s}$ ( $T_{vj} = 150\text{ °C}$ )	$T_{vj} = 25\text{ °C}$	0.512		mJ
			$T_{vj} = 125\text{ °C}$	0.994		
			$T_{vj} = 150\text{ °C}$	1.16		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.01		K/W
Temperature under switching conditions	$T_{vj\text{op}}$		-40		150	$^{\circ}\text{C}$

## 7 NTC-Thermistor

**Table 13 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	$R_{25}$	$T_{NTC} = 25\text{ °C}$		5		k $\Omega$
Deviation of $R_{100}$	$\Delta R/R$	$T_{NTC} = 100\text{ °C}$ , $R_{100} = 493\text{ }\Omega$	-5		5	%
Power dissipation	$P_{25}$	$T_{NTC} = 25\text{ °C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15\text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15\text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15\text{ K}))]$		3433		K

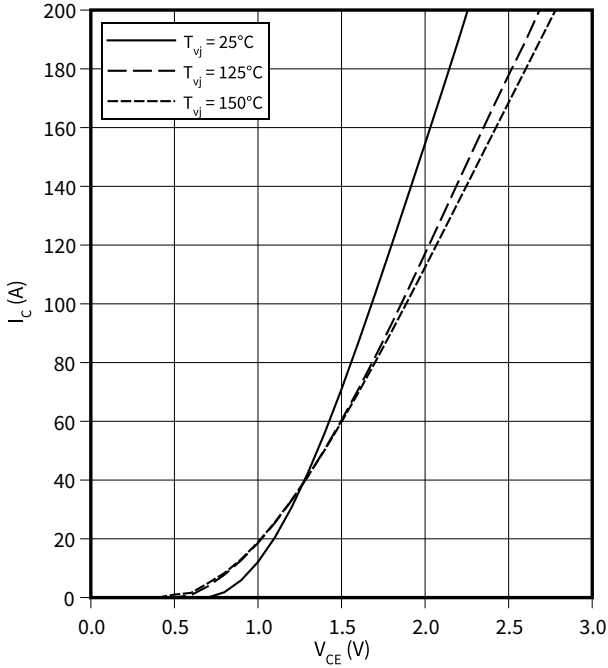
Note: Specification according to the valid application note.

## 8 Characteristics diagrams

### Output characteristic (typical), IGBT, T1 / T4

$$I_C = f(V_{CE})$$

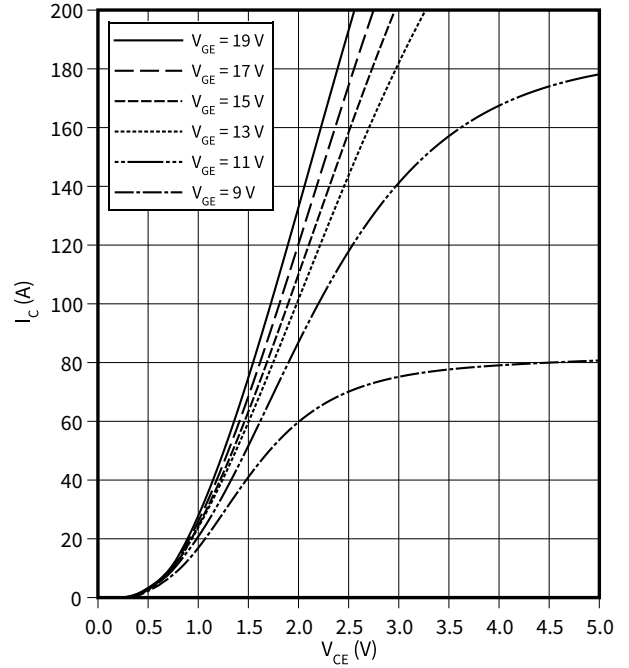
$$V_{GE} = 15 \text{ V}$$



### Output characteristic field (typical), IGBT, T1 / T4

$$I_C = f(V_{CE})$$

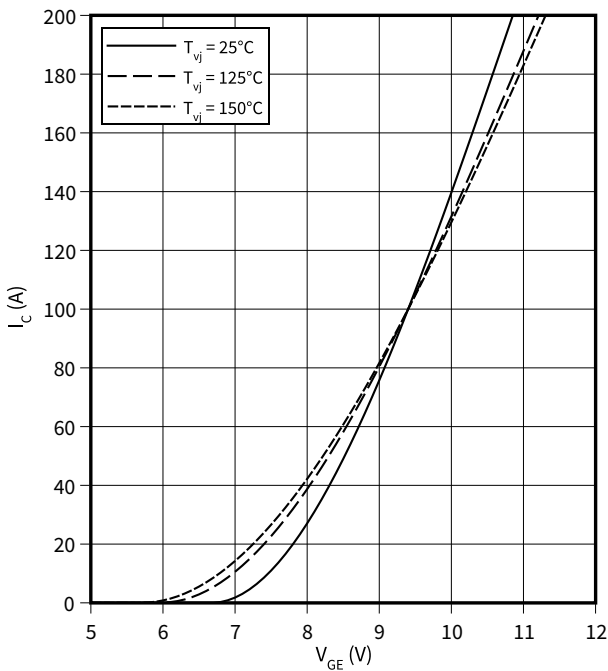
$$T_{vj} = 150 \text{ °C}$$



### Transfer characteristic (typical), IGBT, T1 / T4

$$I_C = f(V_{GE})$$

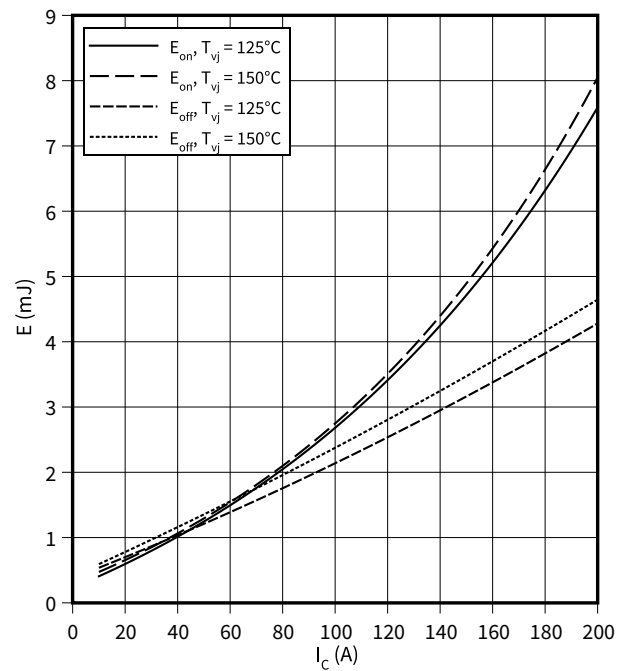
$$V_{CE} = 20 \text{ V}$$



### Switching losses (typical), IGBT, T1 / T4

$$E = f(I_C)$$

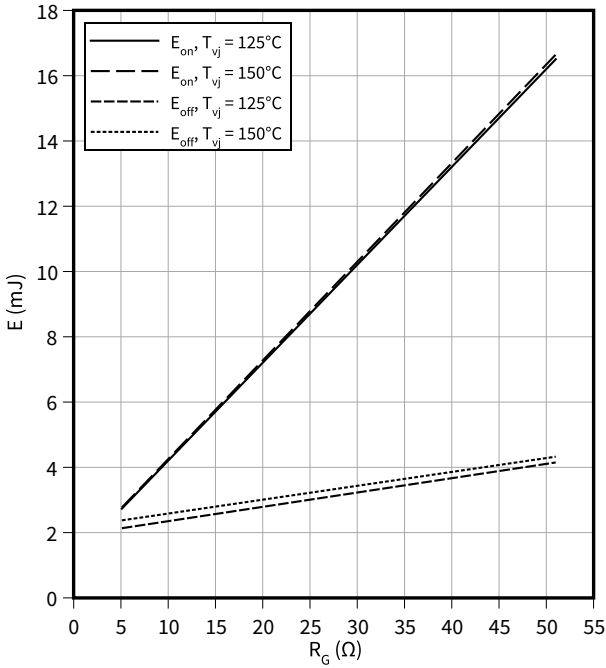
$$R_{Goff} = 5.1 \text{ } \Omega, R_{Gon} = 5.1 \text{ } \Omega, V_{CE} = 300 \text{ V}, V_{GE} = \pm 15 \text{ V}$$



**Switching losses (typical), IGBT, T1 / T4**

$E = f(R_G)$

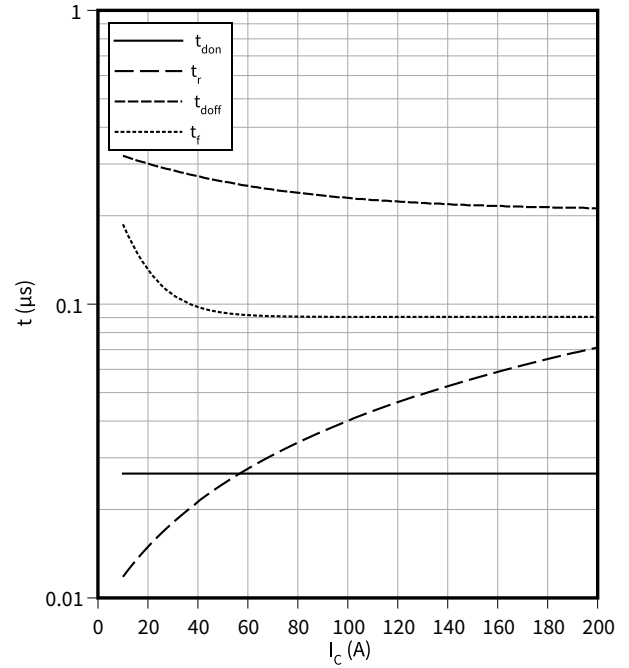
$I_C = 100 \text{ A}$ ,  $V_{CE} = 300 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$



**Switching times (typical), IGBT, T1 / T4**

$t = f(I_C)$

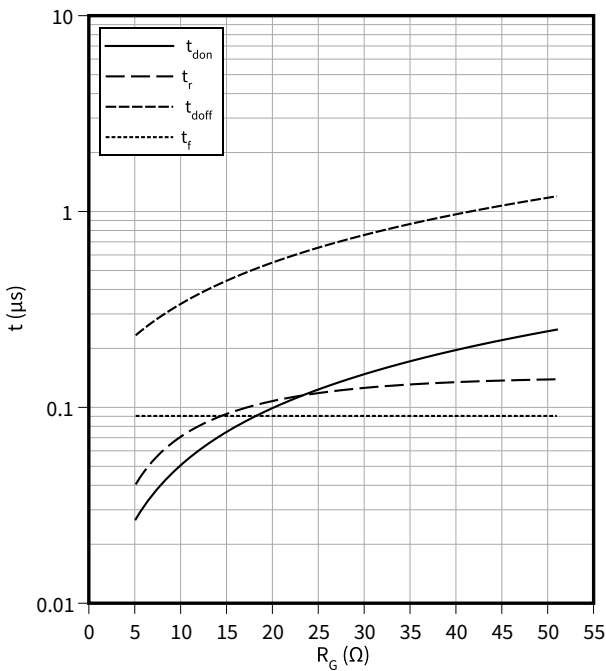
$R_{Goff} = 5.1 \Omega$ ,  $R_{Gon} = 5.1 \Omega$ ,  $V_{CE} = 300 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $T_{vj} = 150 \text{ °C}$



**Switching times (typical), IGBT, T1 / T4**

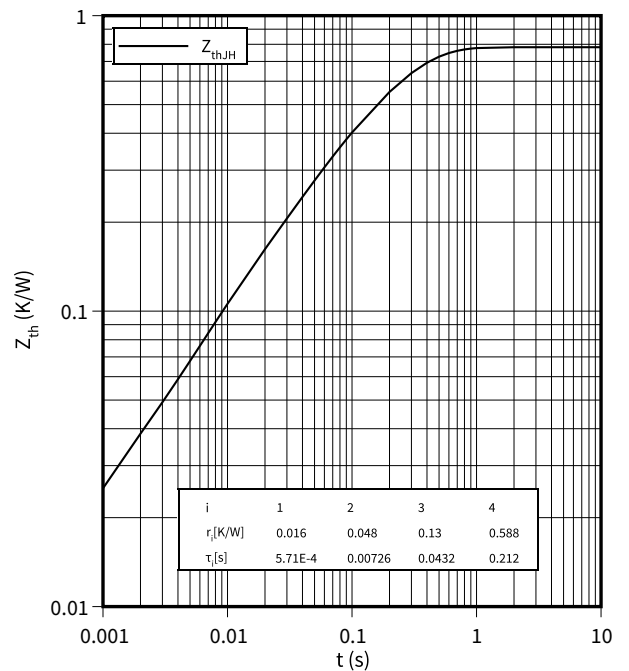
$t = f(R_G)$

$I_C = 100 \text{ A}$ ,  $V_{CE} = 300 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $T_{vj} = 150 \text{ °C}$



**Transient thermal impedance, IGBT, T1 / T4**

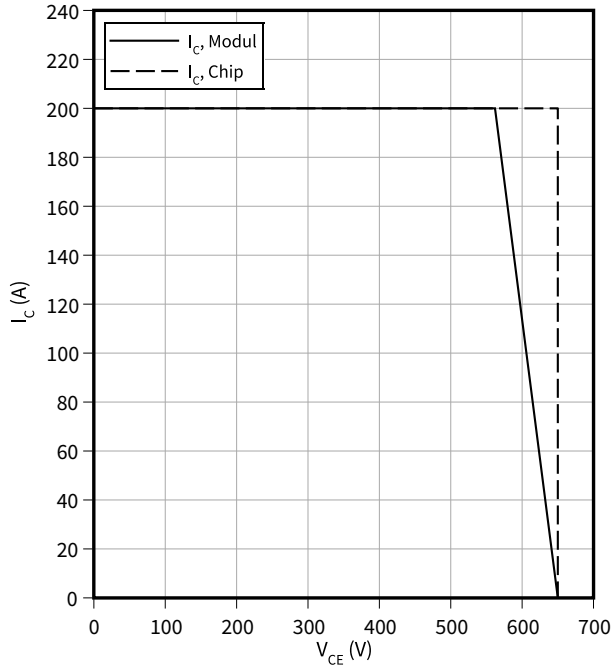
$Z_{th} = f(t)$



**Reverse bias safe operating area (RBSOA), IGBT, T1 / T4**

$I_C = f(V_{CE})$

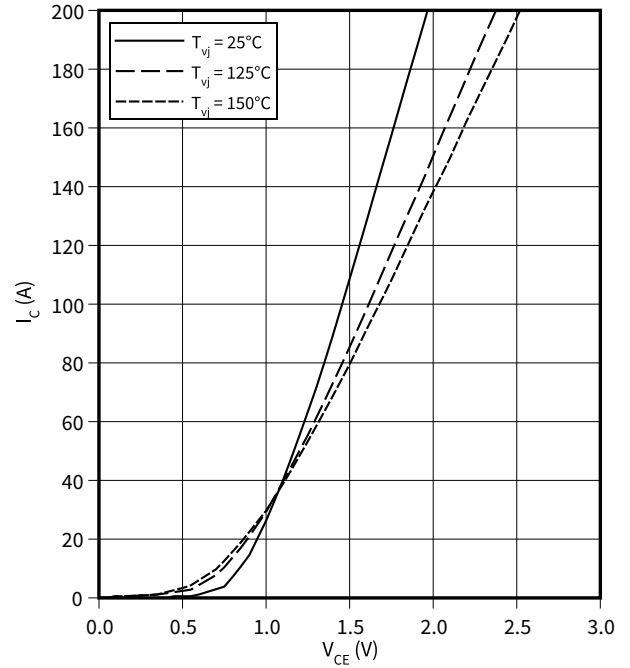
$R_{Goff} = 5.1 \Omega, V_{GE} = \pm 15 V, T_{vj} = 150 \text{ }^\circ\text{C}$



**Output characteristic (typical), IGBT, T2 / T3**

$I_C = f(V_{CE})$

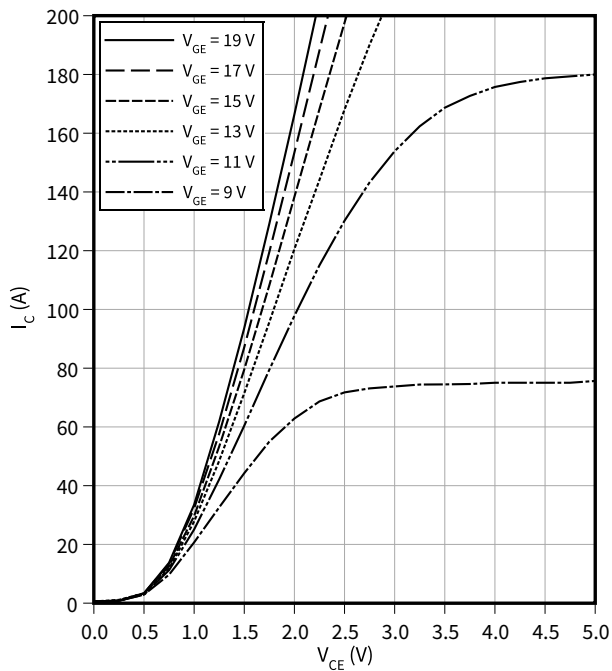
$V_{GE} = 15 V$



**Output characteristic field (typical), IGBT, T2 / T3**

$I_C = f(V_{CE})$

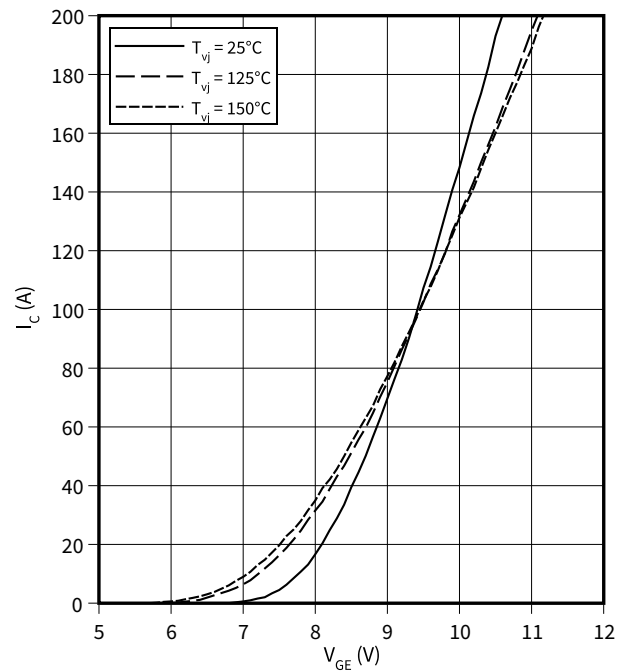
$T_{vj} = 150 \text{ }^\circ\text{C}$



**Transfer characteristic (typical), IGBT, T2 / T3**

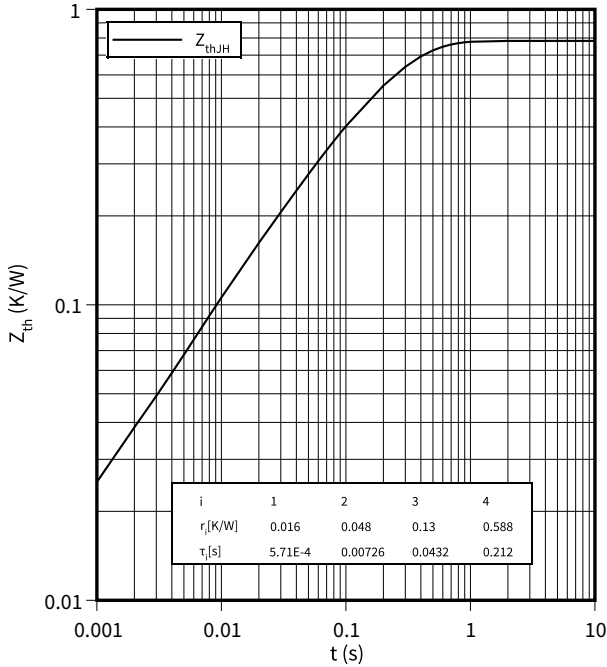
$I_C = f(V_{GE})$

$V_{CE} = 20 V$



**Transient thermal impedance, IGBT, T2 / T3**

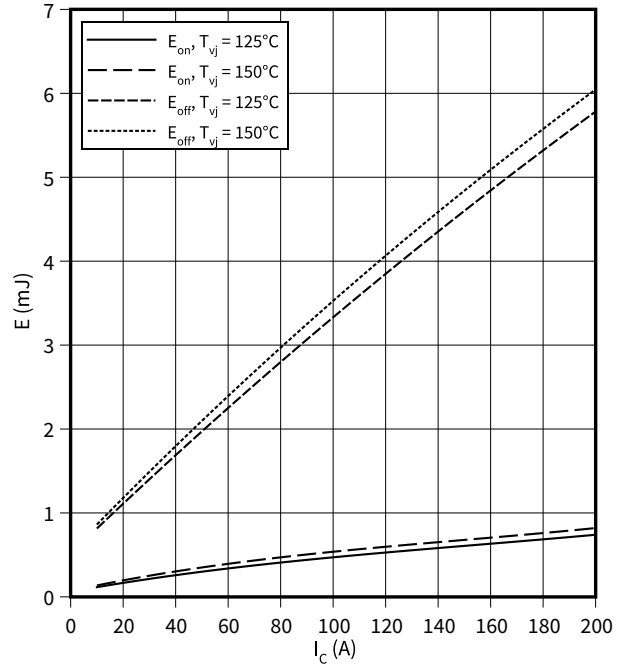
$Z_{th} = f(t)$



**Switching losses (typical), IGBT, T2 / T3**

$E = f(I_C)$

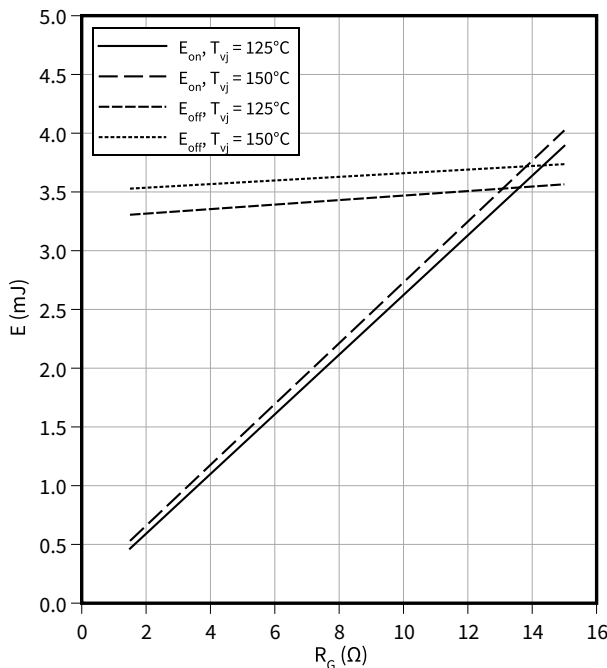
$R_{Goff} = 1.5 \Omega$ ,  $R_{Gon} = 1.5 \Omega$ ,  $V_{GE} = \pm 15 V$ ,  $V_{CE} = 300 V$



**Switching losses (typical), IGBT, T2 / T3**

$E = f(R_G)$

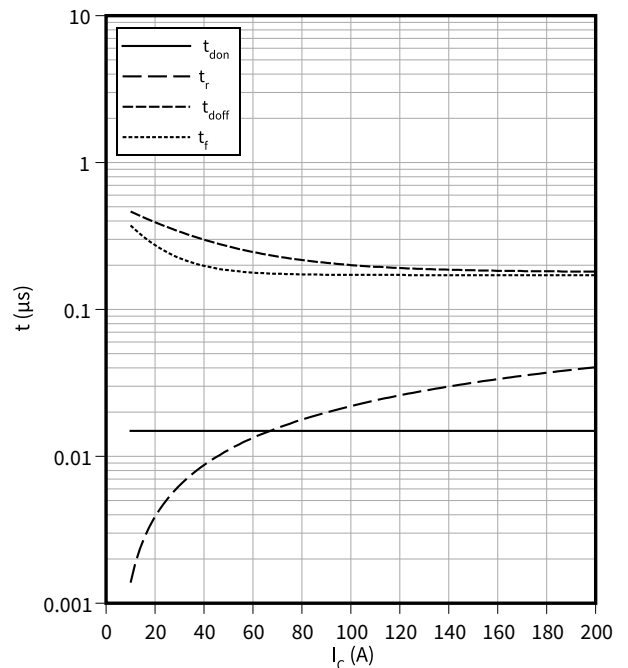
$V_{GE} = \pm 15 V$ ,  $I_C = 100 A$ ,  $V_{CE} = 300 V$



**Switching times (typical), IGBT, T2 / T3**

$t = f(I_C)$

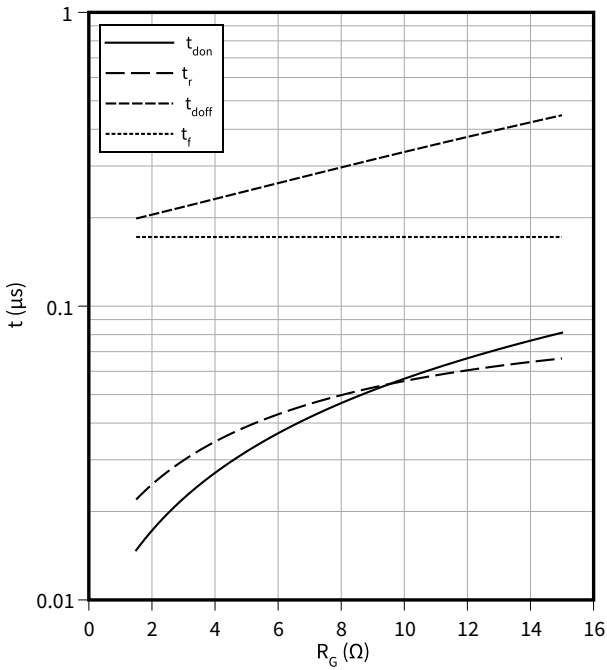
$R_{Goff} = 1.5 \Omega$ ,  $R_{Gon} = 1.5 \Omega$ ,  $V_{GE} = \pm 15 V$ ,  $V_{CE} = 300 V$ ,  $T_{vj} = 150 \text{ °C}$



**Switching times (typical), IGBT, T2 / T3**

$t = f(R_G)$

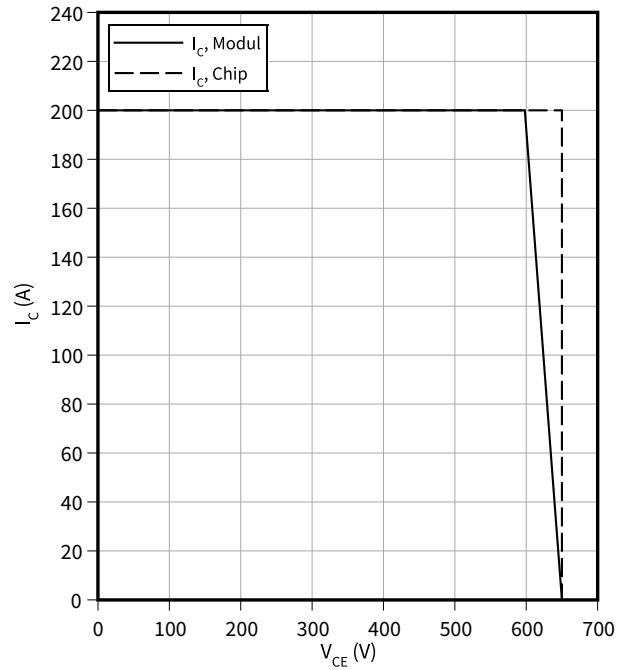
$V_{GE} = \pm 15 \text{ V}$ ,  $I_C = 100 \text{ A}$ ,  $V_{CE} = 300 \text{ V}$ ,  $T_{vj} = 150 \text{ }^\circ\text{C}$



**Reverse bias safe operating area (RBSOA), IGBT, T2 / T3**

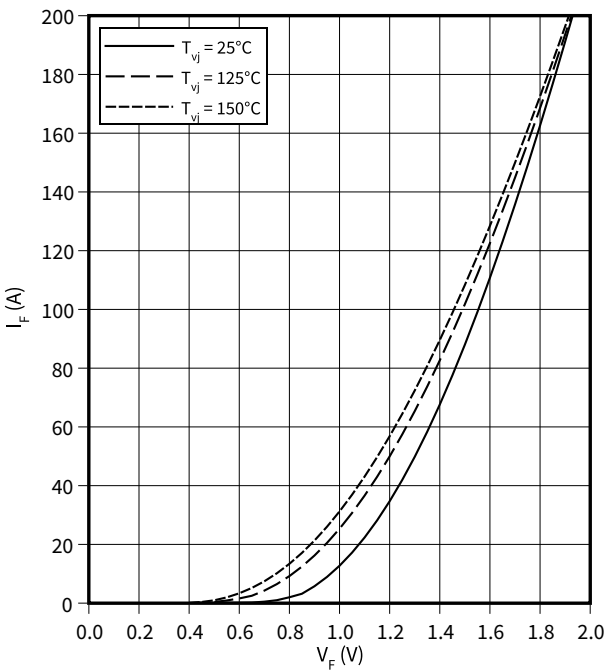
$I_C = f(V_{CE})$

$R_{Goff} = 1.5 \text{ } \Omega$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $T_{vj} = 150 \text{ }^\circ\text{C}$



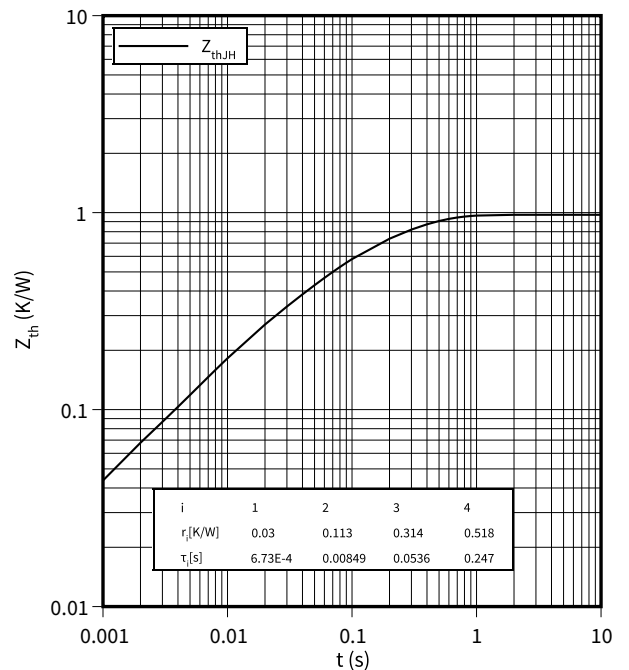
**Forward characteristic (typical), Diode, D1 / D4**

$I_F = f(V_F)$



**Transient thermal impedance, Diode, D1 / D4**

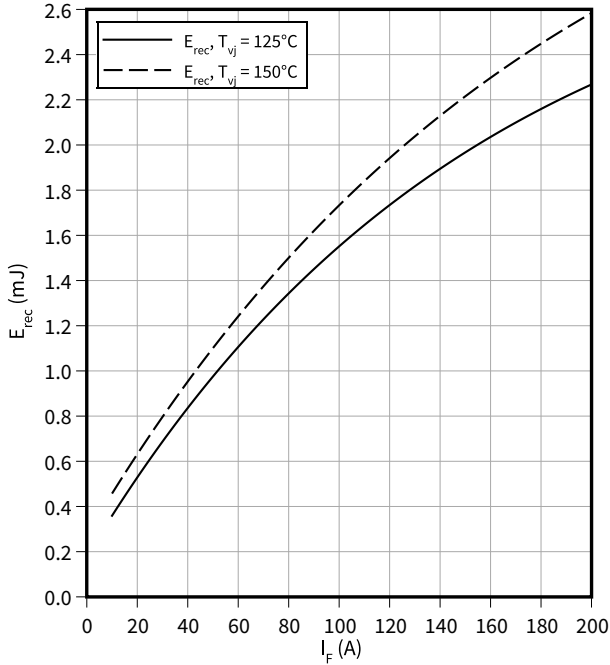
$Z_{th} = f(t)$



**Switching losses (typical), Diode, D1 / D4**

$E_{rec} = f(I_F)$

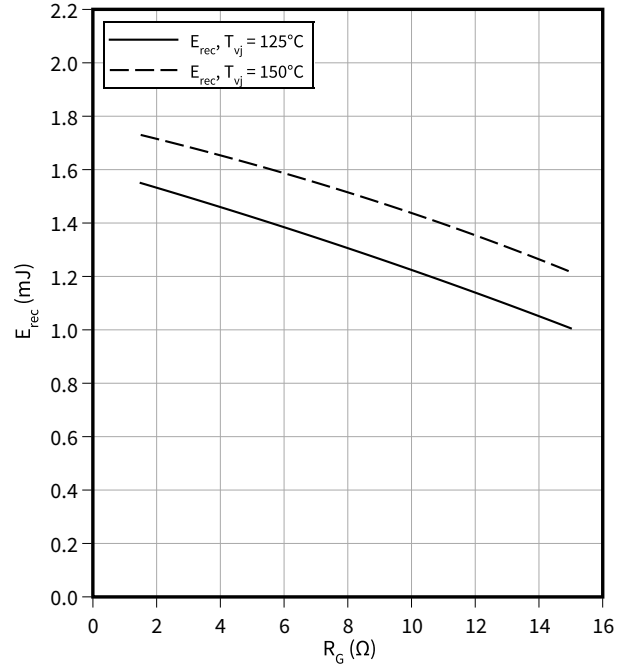
$R_{Gon} = 1.5 \Omega, V_R = 300 V$



**Switching losses (typical), Diode, D1 / D4**

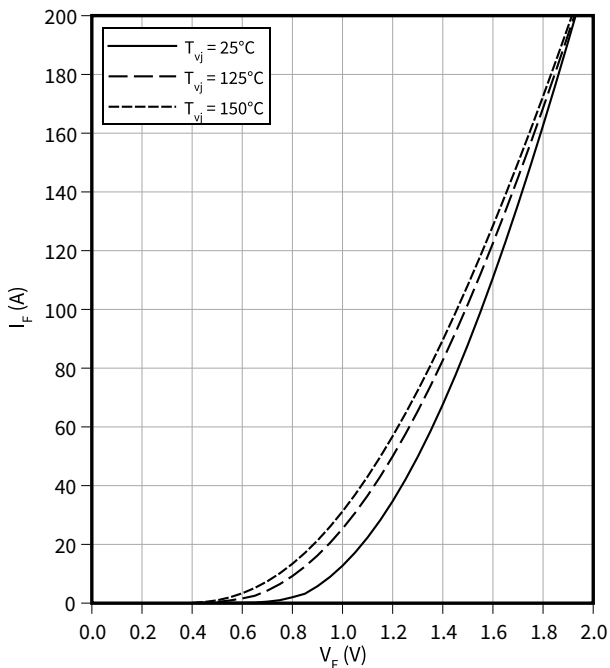
$E_{rec} = f(R_G)$

$I_F = 100 A, V_R = 300 V$



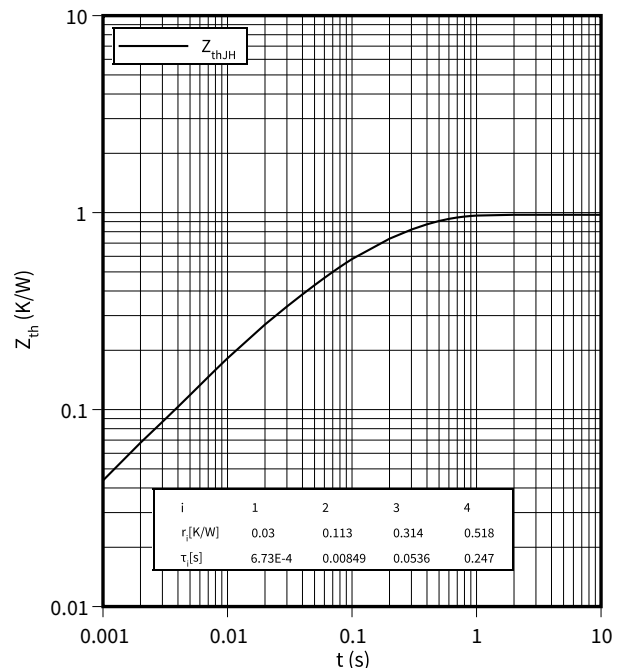
**Forward characteristic (typical), Diode, D2 / D3**

$I_F = f(V_F)$



**Transient thermal impedance, Diode, D2 / D3**

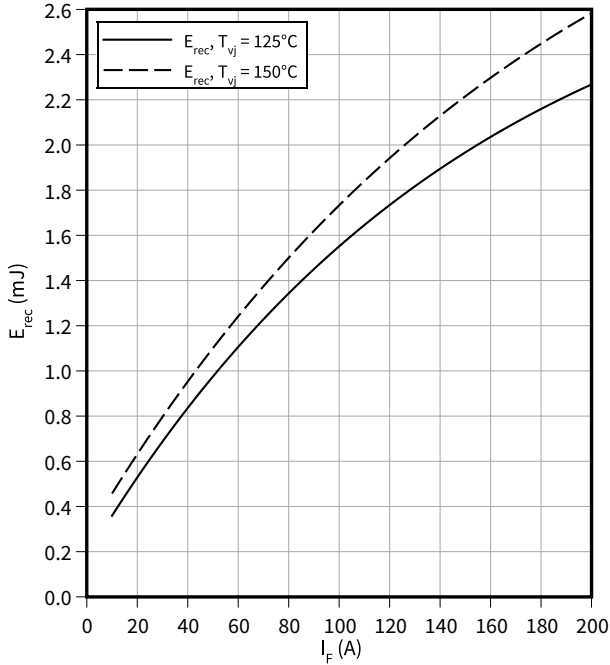
$Z_{th} = f(t)$



**Switching losses (typical), Diode, D2 / D3**

$E_{rec} = f(I_F)$

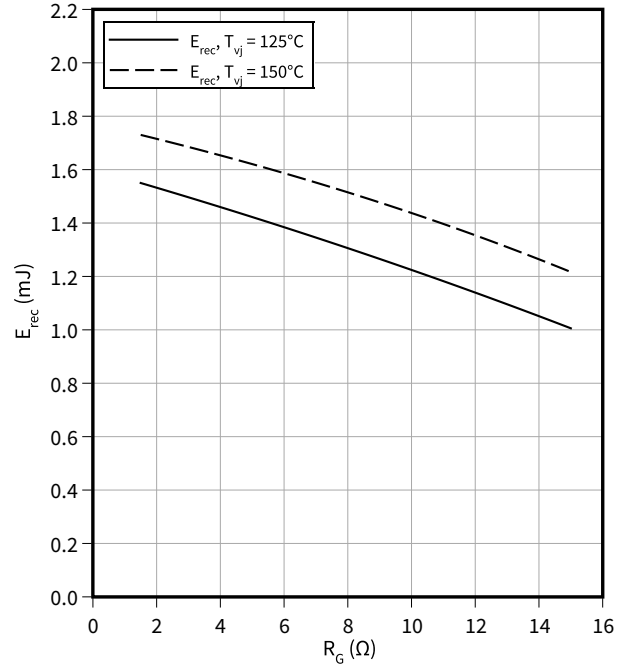
$R_{Gon} = 1.5 \Omega, V_R = 300 V$



**Switching losses (typical), Diode, D2 / D3**

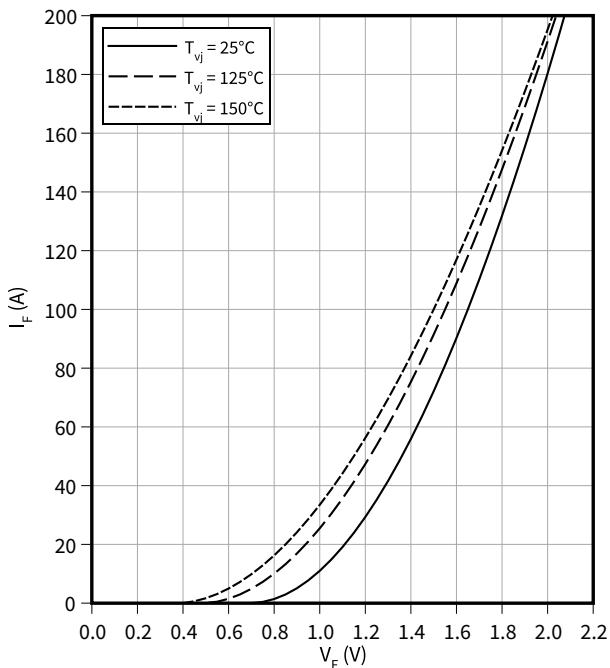
$E_{rec} = f(R_G)$

$I_F = 100 A, V_R = 300 V$



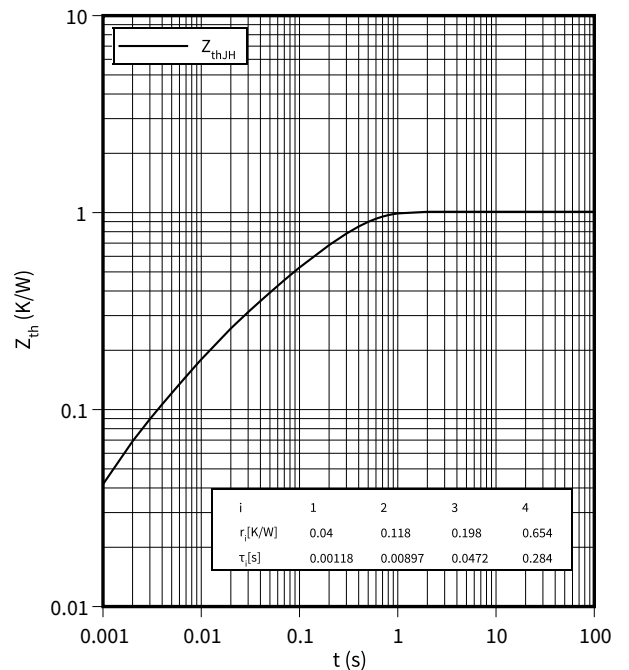
**Forward characteristic (typical), Diode, D5 / D6**

$I_F = f(V_F)$



**Transient thermal impedance, Diode, D5 / D6**

$Z_{th} = f(t)$

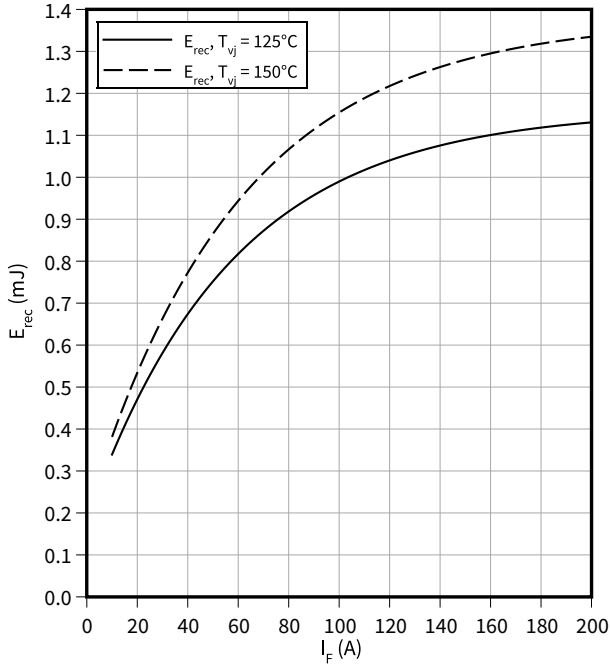




**Switching losses (typical), Diode, D5 / D6**

$E_{rec} = f(I_F)$

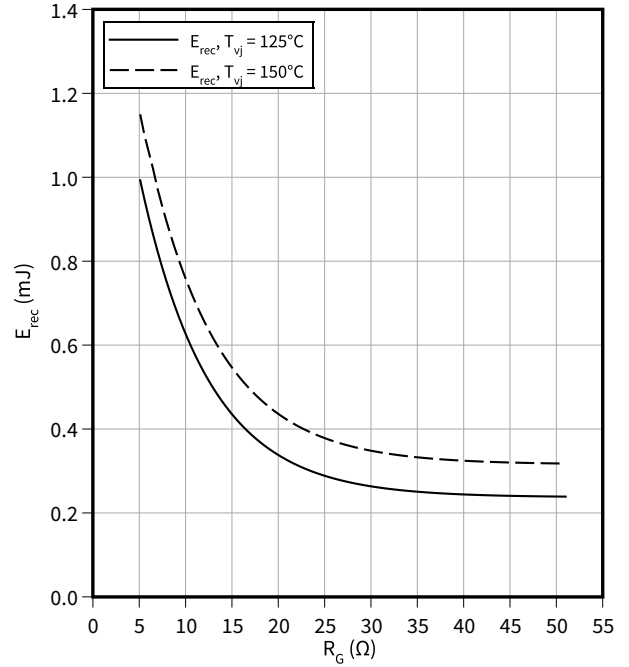
$R_{Gon} = 5.1 \Omega, V_R = 300 V$



**Switching losses (typical), Diode, D5 / D6**

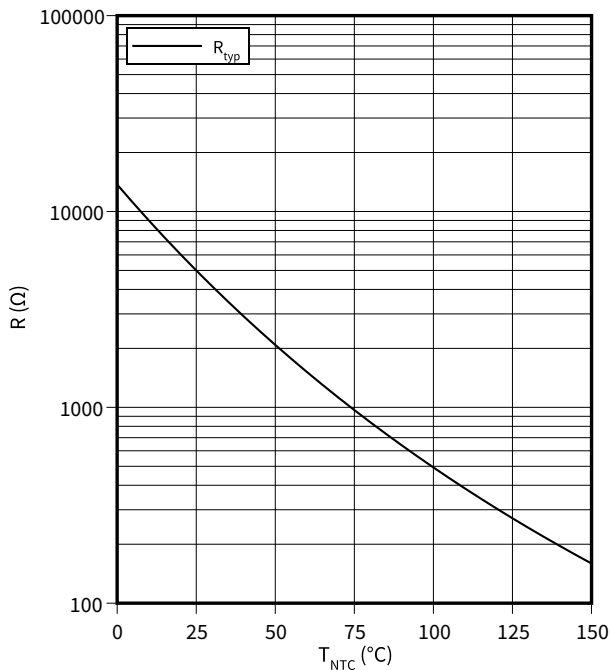
$E_{rec} = f(R_G)$

$I_F = 100 A, V_R = 300 V$



**Temperature characteristic (typical), NTC-Thermistor**

$R = f(T_{NTC})$



## 9 Circuit diagram

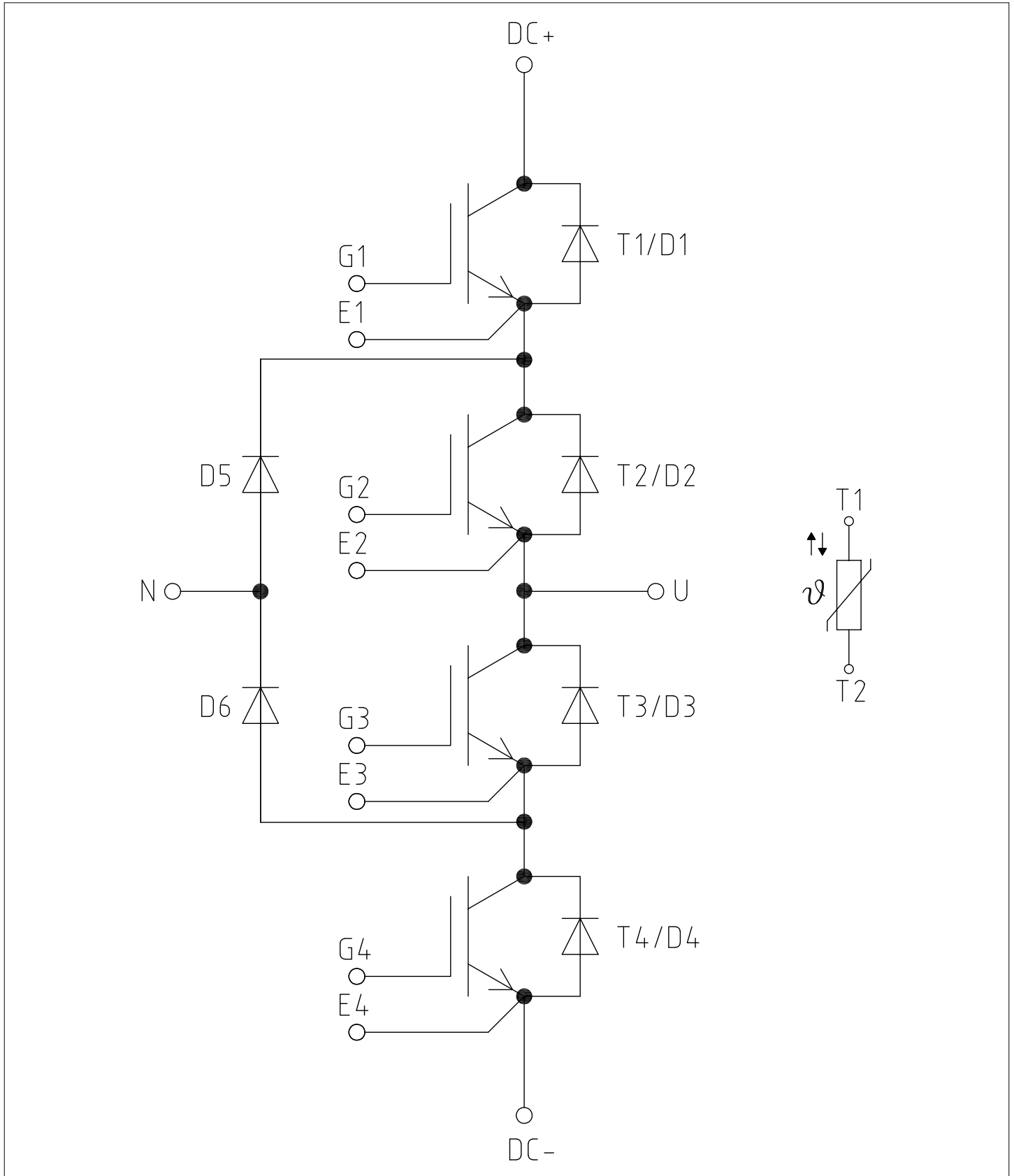


Figure 1

## 10 Package outlines

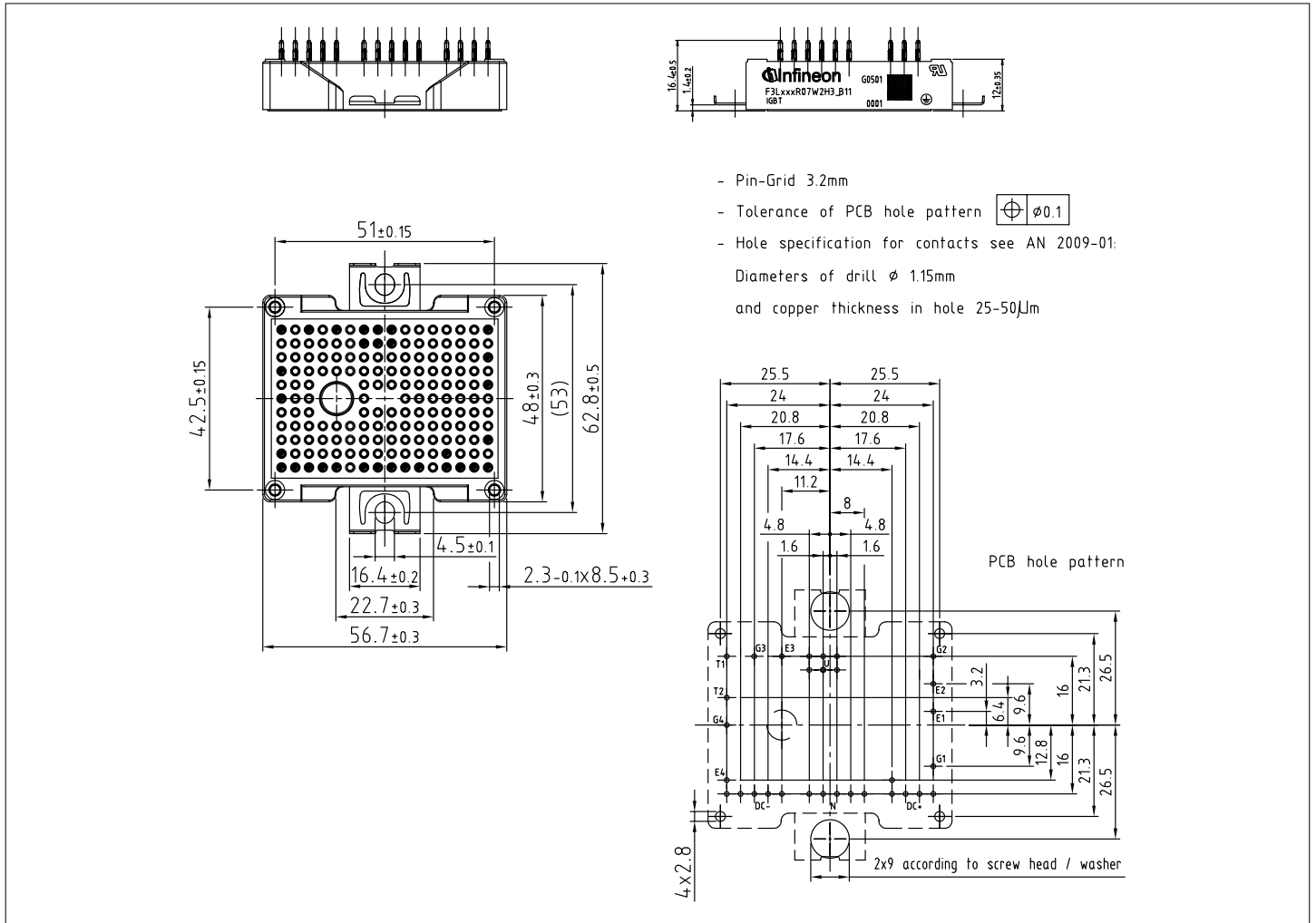

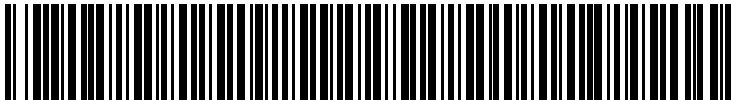


Figure 2

## 11 Module label code

Module label code			
Code format	Data Matrix	Barcode Code128	
Encoding	ASCII text	Code Set A	
Symbol size	16x16	23 digits	
Standard	IEC24720 and IEC16022	IEC8859-1	
Code content	<i>Content</i>	<i>Digit</i>	<i>Example</i>
	Module serial number	1 - 5	71549
	Module material number	6 - 11	142846
	Production order number	12 - 19	55054991
	Date code (production year)	20 - 21	15
	Date code (production week)	22 - 23	30
Example	 		
	71549142846550549911530		71549142846550549911530

**Figure 3**

## Revision history

Document revision	Date of release	Description of changes
0.10	2021-09-09	Target datasheet
1.00	2021-12-09	Final datasheet

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**Document reference**

**IFX-ABA972-002**

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